PROBE CARD

ABSTRACT OF THE DISCLOSURE

A probe card includes a substrate, a bump, a probe and a combining member. The bump is formed on the substrate. The probe includes a support beam and a tip protruded from a first end of the support beam. The combining member electrically connects the bump to the probe. The combining member includes a first combining portion and a second combining portion surrounding an outer face of the first combining portion. Thus, the probe of the probe card may be firmly fixed so that the probe card may have improved structural stability.

FIG. 1 accompanies the abstract.